



# CERTIFICATE OF ACCREDITATION

## The ANSI National Accreditation Board

Hereby attests that

**Transcat-Pittsburgh**  
454 Berlin Plank Road  
Somerset, PA 15501

Fulfills the requirements of

**ISO/IEC 17025:2017**

and the national standards

**ANSI/NCSL Z540-1-1994 (R2002) AND**  
**ANSI/NCSL Z540.3-2006 (R2013)**

In the field of

**CALIBRATION**

This certificate is valid only when accompanied by a current scope of accreditation document.  
The current scope of accreditation can be verified at [www.anab.org](http://www.anab.org).

Jason Stine, Vice President

Expiry Date: 19 January 2027  
Certificate Number: AC-2489.15



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.  
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory  
quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

**SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017**

**AND**

**ANSI/NCSL Z540-1-1994 (R2002)**

**ANSI/NCSL Z540.3-2006 (R2013)**

**Transcat-Pittsburgh**

454 Berlin Plank Road

Somerset, PA 15501

Dennis Kuhn 814-701-2316

**CALIBRATION**

ISO/IEC 17025 Accreditation Granted: **20 November 2025**

Certificate Number: **AC-2489.15** Certificate Expiry Date: **19 January 2027**

**Chemical Quantities**

<b>Parameter/Equipment</b>	<b>Range</b>	<b>Expanded Uncertainty of Measurement (+/-)</b>	<b>Reference Standard, Method, and/or Equipment</b>
pH Meters	4 pH	0.012 pH	Comparison to Accredited Solutions
	7 pH	0.011 pH	
	10 pH	0.012 pH	
Conductivity Meters	1 µS	0.3 µS	Comparison to Accredited Solutions
	10 µS	0.3 µS	
	100 µS	2.1 µS	
	1 000 µS	5 µS	
	1 413 µS	4 µS	
	10 000 µS	44 µS	
	100 000 µS	330 µS	
	150 000 µS	570 µS	
200 000 µS	670 µS		

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC Voltage – Source <sup>1</sup>	(0 to 220) mV (0.22 to 2.2) V (2.2 to 11) V (11 to 22) V (22 to 220) V	8.6 $\mu\text{V/V} + 0.4 \mu\text{V}$ 5.1 $\mu\text{V/V} + 0.7 \mu\text{V}$ 4 $\mu\text{V/V} + 2.5 \mu\text{V}$ 3.9 $\mu\text{V/V} + 4 \mu\text{V}$ 6.2 $\mu\text{V/V} + 40 \mu\text{V}$	Comparison to Fluke 5700A/EP Multiproduct Calibrator
DC Voltage – Source <sup>1</sup>	220 V to 1.1 kV	7.6 $\mu\text{V/V} + 0.4 \text{ mV}$	Comparison to Fluke 5700A/5725A Multiproduct Calibrator with Amplifier
DC Voltage – Measure <sup>1</sup>	(0 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 500) V (500 to 800) V (800 to 1 000) V	8.3 $\mu\text{V/V} + 0.58 \mu\text{V}$ 5.3 $\mu\text{V/V} + 0.58 \mu\text{V}$ 5.3 $\mu\text{V/V} + 0.58 \mu\text{V}$ 7.7 $\mu\text{V/V} + 35 \mu\text{V}$ 15 $\mu\text{V/V} + 0.12 \text{ mV}$ 18 $\mu\text{V/V} + 0.12 \text{ mV}$ 21 $\mu\text{V/V} + 0.12 \text{ mV}$	Comparison to Agilent 3458A Opt. 002 8.5 Digit Multimeter
DC High Voltage – Measure <sup>1</sup>	(1 to 10) kV (10 to 20) kV (20 to 70) kV (70 to 100) kV	0.04 % of reading + 92 mV 0.09 % of reading + 2.4 V 0.09 % of reading + 2.4 V 0.17 % of reading + 2.5 V	Comparison to Vitretek 4700 Digital HV Meter, Associated High Voltage Probes
DC Current – Source <sup>1</sup>	(0.22 to 220) $\mu\text{A}$ (0.22 to 2.2) mA (2.2 to 22) mA (22 to 220) mA (0.22 to 2.2) A	40 $\mu\text{A/A} + 6 \text{ nA}$ 36 $\mu\text{A/A} + 7 \text{ nA}$ 35 $\mu\text{A/A} + 40 \text{ nA}$ 48 $\mu\text{A/A} + 0.7 \mu\text{A}$ 84 $\mu\text{A/A} + 12 \mu\text{A}$	Comparison to Fluke 5700A/EP Multiproduct Calibrator
DC Current – Source <sup>1</sup>	(2.2 to 11) A	0.036 % of reading + 0.48 mA	Comparison to Fluke 5700A/5725A Multiproduct Calibrator with Amplifier
DC Current – Source <sup>1</sup>	(11 to 20.5) A	0.093 % of reading + 0.58 mA	Comparison to Fluke 5522A Multiproduct Calibrator
DC Current – Source <sup>1,8</sup>	(20 to 33) A (33 to 100) A	0.012 % of reading + 5 mA 0.012 % of reading + 5 mA	Comparison to Fluke 5520A Multiproduct Calibrator, Fluke 52120A Transconductance Amplifier

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC Current – Measure <sup>1</sup>	(0 to 100) $\mu$ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	33 $\mu$ A/A + 0.92 nA 29 $\mu$ A/A + 5.8 nA 29 $\mu$ A/A + 58 nA 46 $\mu$ A/A + 0.58 $\mu$ A 0.013 % of reading + 12 $\mu$ A	Comparison to Agilent 3458A Opt. 002 8.5 Digit Multimeter
DC Current – Measure <sup>1</sup>	(1 to 10) A (10 to 100) A (100 to 300) A	0.012 % of reading + 58 $\mu$ A 0.059 % of reading + 0.58 mA 0.12 % of reading + 1.7 mA	Comparison to Agilent 3458A Opt. 002 8.5 Digit Multimeter, Guideline Current Shunt
DC Clamp-on Ammeters (Non-Toroidal Type) Transformer Type Sensor <sup>1</sup>	(20 to 150) A (150 to 1 000) A	0.51 % of reading + 0.14 A 0.51 % of reading + 0.5 A	Comparison to Fluke 5520A Multiproduct Calibrator, Fluke 5500A/COIL 50-turn Coil
DC Clamp-on Ammeter (Non-Toroidal Type) Transformer Type Sensor <sup>1,8</sup>	(1 to 5) kA	0.73 % of reading	Comparison to Fluke 52120A Transconductance Amplifier, Fluke 5520A Multiproduct Calibrator, 3 kA or 6 kA Coil
AC Voltage – Source <sup>1</sup>	Up to 2.2 mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz (2.2 to 22) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.16 % of reading + 4 $\mu$ V 0.1 % of reading + 4 $\mu$ V 0.078 % of reading + 4 $\mu$ V 0.13 % of reading + 4 $\mu$ V 0.17 % of reading + 5 $\mu$ V 0.33 % of reading + 10 $\mu$ V 0.47 % of reading + 20 $\mu$ V 0.58 % of reading + 20 $\mu$ V 0.042 % of reading + 4 $\mu$ V 0.03 % of reading + 4 $\mu$ V 0.014 % of reading + 4 $\mu$ V 0.03 % of reading + 4 $\mu$ V 0.058 % of reading + 5 $\mu$ V 0.12 % of reading + 10 $\mu$ V 0.16 % of reading + 20 $\mu$ V 0.27 % of reading + 20 $\mu$ V	Comparison to Fluke 5700A/EP Multiproduct Calibrator

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source <sup>1</sup>	(22 to 220) mV		Comparison to Fluke 5700A/EP Multiproduct Calibrator
	(10 to 20) Hz	0.028 % of reading + 12 μV	
	(20 to 40) Hz	0.011 % of reading + 7 μV	
	40 Hz to 20 kHz	0.008 5 % of reading + 7 μV	
	(20 to 50) kHz	0.021 % of reading + 7 μV	
	(50 to 100) kHz	0.047 % of reading + 17 μV	
	(100 to 300) kHz	0.091 % of reading + 20 μV	
	(300 to 500) kHz	0.14 % of reading + 25 μV	
	500 kHz to 1 MHz	0.28 % of reading + 45 μV	
	(0.22 to 2.2) V		
	(10 to 20) Hz	0.027 % of reading + 40 μV	
	(20 to 40) Hz	0.01 % of reading + 15 μV	
	40 Hz to 20 kHz	0.004 8 % of reading + 8 μV	
	(20 to 50) kHz	0.008 % of reading + 10 μV	
	(50 to 100) kHz	0.012 % of reading + 30 μV	
	(100 to 300) kHz	0.043 % of reading + 80 μV	
	(300 to 500) kHz	0.1 % of reading + 0.2 mV	
	500 kHz to 1 MHz	0.18 % of reading + 0.3 mV	
	(2.2 to 22) V		
	(10 to 20) Hz	0.028 % of reading + 0.4 mV	
	(20 to 40) Hz	0.01 % of reading + 0.15 mV	
	40 Hz to 20 kHz	0.004 9 % of reading + 50 μV	
	(20 to 50) kHz	0.008 3 % of reading + 0.1 mV	
	(50 to 100) kHz	0.011 % of reading + 0.2 mV	
	(100 to 300) kHz	0.03 % of reading + 0.6 mV	
	(300 to 500) kHz	0.1 % of reading + 2 mV	
	500 kHz to 1 MHz	0.17 % of reading + 3.2 mV	
(22 to 220) V			
(10 to 20) Hz	0.028 % of reading + 4 mV		
(20 to 40) Hz	0.01 % of reading + 1.5 mV		
40 Hz to 20 kHz	0.005 6 % of reading + 0.6 mV		
(20 to 50) kHz	0.009 3 % of reading + 1 mV		
(50 to 100) kHz	0.016 % of reading + 2.5 mV		
(100 to 300) kHz	0.09 % of reading + 16 mV		
(300 to 500) kHz	0.44 % of reading + 40 mV		
500 kHz to 1 MHz	0.8 % of reading + 80 mV		

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source <sup>1</sup>	(220 to 750) V (30 to 50) kHz (50 to 100) kHz	0.061 % of reading + 11 mV 0.23 % of reading + 45 mV	Comparison to Fluke 5700A/5725A Multiproduct Calibrator with Amplifier
	(220 to 1 100) V 40 Hz to 1 kHz (1 to 20) kHz (20 to 30) kHz	0.011 % of reading + 4 mV 0.017 % of reading + 6 mV 0.061 % of reading + 11 mV	
AC Voltage – Measure <sup>1</sup>	Up to 10 mV (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz (1 to 4) MHz	0.04 % of reading + 3.5 μV 0.03 % of reading + 1.2 μV 0.04 % of reading + 1.2 μV 0.15 % of reading + 1.2 μV 0.59 % of reading + 1.2 μV 4.6 % of reading + 2.3 μV 1.5 % of reading + 5.8 μV 8.1 % of reading + 8.1 μV	Comparison to Agilent 3458A Opt. 002 8.5 Digit Multimeter
	(10 to 100) mV (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz (0.1 to 1) V (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz	0.013 % of reading + 4.6 μV 0.009 7 % of reading + 2.3 μV 0.017 % of reading + 2.3 μV 0.038 % of reading + 2.3 μV 0.093 % of reading + 2.3 μV 0.36 % of reading + 12 μV 1.2 % of reading + 12 μV 1.8 % of reading + 12 μV 4.7 % of reading + 81 μV 4.7 % of reading + 92 μV 17 % of reading + 0.12 mV 0.008 8 % of reading + 46 μV 0.008 3 % of reading + 23 μV 0.017 % of reading + 23 μV 0.036 % of reading + 23 μV 0.093 % of reading + 23 μV 0.35 % of reading + 0.12 mV 1.2 % of reading + 0.12 mV 1.8 % of reading + 0.12 mV 4.6 % of reading + 81 μV 4.6 % of reading + 0.92 mV 17 % of reading + 1.2 mV	

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Measure <sup>1</sup>	(1 to 10) V (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz (2 to 4) MHz (4 to 8) MHz (8 to 10) MHz (10 to 100) V (1 to 40) Hz 40Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (100 to 700) V (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.01 % of reading + 0.46 mV 0.023 % of reading + 0.23 mV 0.017 % of reading + 0.23 mV 0.036 % of reading + 0.23 mV 0.093 % of reading + 0.23 mV 0.35 % of reading + 1.2 mV 1.2 % of reading + 1.2 mV 1.8 % of reading + 1.2 mV 4.6 % of reading + 8.1 mV 4.6 % of reading + 9.2 mV 17 % of reading + 12 mV 0.024 % of reading + 4.6 mV 0.024 % of reading + 2.3 mV 0.024 % of reading + 2.3 mV 0.041 % of reading + 2.3 mV 0.14 % of reading + 2.3 mV 0.46 % of reading + 12 mV 1.7 % of reading + 12 mV 0.048 % of reading + 46 mV 0.048 % of reading + 23 mV 0.071 % of reading + 23 mV 0.19 % of reading + 23 mV 0.35 % of reading + 23 mV	Comparison to Agilent 3458A Opt. 002 8.5 Digit Multimeter
AC High Voltage – Measure <sup>1</sup>	(0.7 to 10) kV (20 to 100) Hz (100 to 400) Hz (10 to 30) kV (30 to 70) Hz (70 to 200) Hz (200 to 450) Hz (30 to 50) kV (30 to 70) Hz (70 to 200) Hz (200 to 450) Hz (50 to 70) kV (30 to 70) Hz (70 to 200) Hz	0.14 % of reading + 0.37 V 0.48 % of reading + 0.17 V 0.11 % of reading + 2.4 V 0.7 % of reading + 2.4 V 1.4 % of reading + 2.4 V 0.13 % of reading + 2.5 V 0.7 % of reading + 2.5 V 2.9 % of reading + 2.5 V 0.16 % of reading + 2.6 V 1.2 % of reading + 2.6 V	Comparison to Vitrek 4700 Digital HV Meter, Associated High Voltage Probes

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current – Source <sup>1</sup>	Up to 220 $\mu$ A (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (0.22 to 2.2) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (2.2 to 22) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (22 to 220) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (0.22 to 2.2) A 20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (2.2 to 11) A (40 to 100) Hz (1 to 5) kHz (5 to 10) kHz	0.031 % of reading + 16 nA 0.019 % of reading + 10 nA 0.015 % of reading + 8 nA 0.03 % of reading + 12 nA 0.11 % of reading + 65 nA 0.03 % of reading + 40 nA 0.018 % of reading + 35 nA 0.013 % of reading + 35 nA 0.021 % of reading + 0.11 $\mu$ A 0.11 % of reading + 0.65 $\mu$ A 0.039 % of reading + 0.4 $\mu$ A 0.019 % of reading + 0.35 $\mu$ A 0.014 % of reading + 0.35 $\mu$ A 0.021 % of reading + 0.5 $\mu$ A 0.11 % of reading + 5 $\mu$ A 0.033 % of reading + 0.4 $\mu$ A 0.018 % of reading + 0.35 $\mu$ A 0.014 % of reading + 0.35 $\mu$ A 0.021 % of reading + 0.55 $\mu$ A 0.11 % of reading + 5 $\mu$ A 0.027 % of reading + 35 $\mu$ A 0.046 % of reading + 80 $\mu$ A 0.7 % of reading + 0.16 mA 0.048 % of reading + 0.17 mA 0.096 % of reading + 0.38 mA 0.36 % of reading + 0.75 mA	Comparison to Fluke 5700A/EP Multiproduct Calibrator
AC Current – Source <sup>1</sup>	(11 to 20) A (45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.095 % of reading + 3.9 mA 0.12 % of reading + 3.9 mA 2.3 % of reading + 3.9 mA	Comparison to Fluke 5522A Multiproduct Calibrator

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current – Source <sup>1,8</sup>	(10 to 45) Hz		Comparison to Fluke 52120A Transconductance Amplifier, Fluke 5520A Multiproduct Calibrator
	(20 to 33) A	0.024 % of reading + 24 mA	
	(33 to 40) A	0.033 % of reading + 24 mA	
	(40 to 60) A	0.02 % of reading + 24 mA	
	(60 to 100) A	0.02 % of reading + 24 mA	
	(45 to 65) Hz		
	(20 to 33) A	0.024 % of reading + 24 mA	
	(33 to 40) A	0.033 % of reading + 24 mA	
	(40 to 60) A	0.033 % of reading + 24 mA	
	(60 to 100) A	0.033 % of reading + 24 mA	
	(65 to 100) Hz		
	(20 to 33) A	0.038 % of reading + 36 mA	
	(33 to 60) A	0.047 % of reading + 36 mA	
	(60 to 100) A	0.047 % of reading + 36 mA	
(100 to 300) Hz			
(20 to 33) A	0.038 % of reading + 36 mA		
(33 to 60) A	0.047 % of reading + 36 mA		
(60 to 100) A	0.047 % of reading + 36 mA		
300 Hz to 1 kHz			
(20 to 33) A	0.12 % of reading + 0.12 A		
(33 to 60) A	0.12 % of reading + 0.12 A		
(60 to 100) A	0.12 % of reading + 0.12 A		
AC Current – Source <sup>1</sup> Extended Frequency Ranges	(29 to 330) μA		Comparison to Fluke 5522A Multiproduct Calibrator
	(10 to 30) kHz	1.2 % of reading + 0.31 μA	
	(0.33 to 3.3) mA		
	(10 to 30) kHz	0.78 % of reading + 0.47 μA	
	(3.3 to 33) mA		
	(10 to 30) kHz	0.31 % of reading + 3.1 μA	
AC Clamp-on Ammeters (Toroidal Type) Transformer Type Sensor <sup>1</sup>	(20 to 150) A		Comparison to Fluke 5522A Multiproduct Calibrator, Fluke 5500A/COIL 50-turn Coil
	(45 to 65) Hz	0.34 % of reading + 26 mA	
	(65 to 440) Hz	0.95 % of reading + 47 mA	
	(150 to 1 000) A		
	(45 to 65) Hz	0.38 % of reading + 0.12 A	
	(65 to 440) Hz	1.2 % of reading + 0.22 A	

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Clamp-on Ammeters (Non-Toroidal Type) Hall Effect Sensor <sup>1</sup>	(20 to 150) A (45z to 65) Hz (65 to 440) Hz (150 to 1 000) A (45 to 65) Hz (65 to 440) Hz	0.66 % of reading + 0.25 A 1.2 % of reading + 0.25 A 0.68 % of reading + 0.90 A 1.4 % of reading + 0.92 A	Comparison to Fluke 5522A Multiproduct Calibrator, Fluke 5500A/COIL 50-turn Coil
AC Clamp-on Ammeters (Non-Toroidal Type) Hall Effect Sensor <sup>1,8</sup>	(1 to 6) kA (10 to 300) Hz (1 to 2) kA (300 to 440) Hz (2 to 6) kA (300 to 440) Hz	0.74 % of reading 0.91 % of reading 0.79 % of reading	Comparison to Fluke 52120A Transconductance Amplifier, Fluke 5520A Multiproduct Calibrator, 3 kA or 6 kA Coil
AC Current – Measure <sup>1</sup>	Up to 100 μA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 1 kHz (0.1 to 1) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (1 to 10) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (10 to 100) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (0.1 to 1) A (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	0.46 % of reading + 35 nA 0.17 % of reading + 35 nA 0.072 % of reading + 35 nA 0.072 % of reading + 35 nA 0.46 % of reading + 0.23 μA 0.17 % of reading + 0.23 μA 0.07 % of reading + 0.23 μA 0.038 % of reading + 0.23 μA 0.46 % of reading + 2.3 μA 0.17 % of reading + 2.3 μA 0.071 % of reading + 2.3 μA 0.038 % of reading + 2.3 μA 0.48 % of reading + 23 μA 0.17 % of reading + 23 μA 0.071 % of reading + 23 μA 0.037 % of reading + 23 μA 0.46 % of reading + 0.23 mA 0.19 % of reading + 0.23 mA 0.097 % of reading + 0.23 mA 0.12 % of reading + 0.23 mA	Comparison to Agilent 3458A Opt. 002 8.5 Digit Multimeter

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current – Measure <sup>1</sup>	(1 to 3) A 10 Hz to 5 kHz (5 to 10) kHz	0.24 % of reading + 0.1 mA 1.2 % of reading + 0.1 mA	Comparison to Fluke 8846A 6.5 Digit Multimeter
	(3 to 10) A 10 Hz to 5 kHz	0.81 % of reading + 0.4 mA	
Resistance – Source <sup>1</sup> (Simulation)	(0 to 11) Ω	2 μΩ/Ω + 0.78 mΩ	Comparison to Fluke 5522A Multiproduct Calibrator
	(11 to 33) Ω	24 μΩ/Ω + 1.2 mΩ	
	(33 to 111) Ω	22 μΩ/Ω + 1.1 mΩ	
	(110 to 330) Ω	22 μΩ/Ω + 1.6 mΩ	
	(0.33 to 1.1) kΩ	22 μΩ/Ω + 1.6 mΩ	
	(1.1 to 3.3) kΩ	22 μΩ/Ω + 1.6 mΩ	
	(3.3 to 11) kΩ	22 μΩ/Ω + 1.6 mΩ	
	(11 to 33) kΩ	22 μΩ/Ω + 0.16 Ω	
	(33 to 110) kΩ	22 μΩ/Ω + 0.16 Ω	
	(110 to 330) kΩ	27 μΩ/Ω + 1.6 Ω	
	(0.33 to 1.1) MΩ	26 μΩ/Ω + 1.6 Ω	
	(1.1 to 3.3) MΩ	66 μΩ/Ω + 23 Ω	
	(3.3 to 11) MΩ	0.1 mΩ/Ω + 39 Ω	
Resistance – Source <sup>1</sup> (Variable Artifact)	(10 to 100) MΩ	0.082 % of reading	Comparison to High Resistance Decade Box (up to 5 kV)
	(0.1 to 1) GΩ	0.24 % of reading	
	(1 to 10) GΩ	0.42 % of reading	
	(10 to 100) GΩ	0.82 % of reading	
	(0.1 to 1) TΩ	2.4 % of reading	
Resistance – Measure <sup>1</sup>	(0 to 10) Ω	18 μΩ/Ω + 58 μΩ	Comparison to Agilent 3458A Opt. 002 8.5 Digit Multimeter
	(10 to 100) Ω	15 μΩ/Ω + 0.58 mΩ	
	(0.1 to 1) kΩ	13 μΩ/Ω + 0.58 mΩ	
	(1 to 10) kΩ	12 μΩ/Ω + 5.8 mΩ	
	(10 to 100) kΩ	13 μΩ/Ω + 58 mΩ	
	(0.1 to 1) MΩ	21 μΩ/Ω + 2.3 Ω	
	(1 to 10) MΩ	62 μΩ/Ω + 0.12 kΩ	
	(10 to 100) MΩ	0.59 % of reading + 1.2 kΩ	
	(0.1 to 1) GΩ	0.82 % of reading + 12 kΩ	

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Electrical Simulation of Thermocouple Indicating Devices – Source/Measure <sup>1</sup>	Type B		Comparison to Fluke 5522A Multiproduct Calibrator
	(600 to 800) °C	0.35 °C	
	(800 to 1 000) °C	0.28 °C	
	(1 000 to 1 550) °C	0.24 °C	
	(1 550 to 1 820) °C	0.26 °C	
	Type E		
	(-250 to -100) °C	0.39 °C	
	(-100 to -25) °C	0.13 °C	
	(-25 to 350) °C	0.12 °C	
	(350 to 650) °C	0.13 °C	
	(650 to 1 000) °C	0.17 °C	
	Type J		
	(-210 to -100) °C	0.21 °C	
	(-100 to -30) °C	0.13 °C	
	(-30 to 150) °C	0.12 °C	
	(150 to 760) °C	0.14 °C	
	(760 to 1 200) °C	0.18 °C	
	Type K		
	(-200 to -100) °C	0.26 °C	
	(-100 to -25) °C	0.15 °C	
	(-25 to 120) °C	0.13 °C	
	(120 to 1 000) °C	0.21 °C	
	(1 000 to 1 372) °C	0.31 °C	
	Type N		
(-200 to -100) °C	0.31 °C		
(-100 to -25) °C	0.18 °C		
(-25 to 120) °C	0.15 °C		
(120 to 410) °C	0.15 °C		
(410 to 1 300) °C	0.21 °C		
Type R			
(0 to 250) °C	0.46 °C		
(250 to 400) °C	0.29 °C		
(400 to 1 000) °C	0.26 °C		
(1 000 to 1 767) °C	0.32 °C		
Type S			
(0 to 250) °C	0.45 °C		
(250 to 1 000) °C	0.30 °C		
(1 000 to 1 400) °C	0.29 °C		
(1 400 to 1 767) °C	0.36 °C		

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Electrical Simulation of Thermocouple Indicating Devices – Source/Measure <sup>1</sup>	Type T (-250 to -150) °C (-150 to 0) °C (0 to 120) °C (120 to 400) °C	0.49 °C 0.19 °C 0.13 °C 0.12 °C	Comparison to Fluke 5522A Multiproduct Calibrator
Electrical Simulation of RTD Indicating Devices – Source <sup>1</sup>	Pt 385, 100 Ω (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C (630 to 800) °C	0.039 °C 0.039 °C 0.054 °C 0.07 °C 0.078 °C 0.093 °C 0.18 °C	Comparison to Fluke 5522A Multiproduct Calibrator
DC Power – Source <sup>1</sup>	(0.33 to 330) mA 11 μW to 1.1 mW (1.1 to 110) mW (0.11 to 110) W (110 to 330) W (0.33 to 3) A 11 μW to 110 mW (0.11 to 990) W 1 W to 3 kW (3 to 20.5) A 99 mW to 0.99 W 0.99 W to 6.8 kW (6.8 to 20.5) kW	0.024 % of reading 0.027 % of reading 0.024 % of reading 0.018 % of reading 0.044 % of reading 0.053 % of reading 0.01 % of reading 0.088 % of reading 0.07 % of reading 0.04 % of reading	Comparison to Fluke 5522A Multiproduct Calibrator
AC Power – Source <sup>1,5</sup> (10 to 65) Hz (PF=1)	(3.3 to 9.0) mA (0.11 to 3) mW 3 mW to 9 W (9 to 33) mA (0.3 to 10) mW 10 mW to 33 W (33 to 90) mA (1 to 30) mW 30 mW to 90 W (90 to 330) mA (3 to 100) mW (0.1 to 300) W (0.33 to 0.9) A (11 to 300) mW (0.3 to 900) W	0.13 % of reading 0.077 % of reading 0.089 % of reading 0.077 % of reading 0.071 % of reading 0.057 % of reading 0.089 % of reading 0.078 % of reading 0.071 % of reading 0.081 % of reading	Comparison to Fluke 5522A Multiproduct Calibrator

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Power – Source <sup>1,5</sup> (10 to 65) Hz (PF=1)	(0.9 to 2.2) A	0.089 % of reading	Comparison to Fluke 5522A Multiproduct Calibrator
	(30 to 720) mW	0.079 % of reading	
	(2.2 to 4.5) A	0.088 % of reading	
	80 mW to 1.4 W	0.18 % of reading	
Phase – Source <sup>1</sup>	(4.5 to 20.5) A	0.17 % of reading	Comparison to Fluke 5522A Multiproduct Calibrator
	(0.15 to 6.7) W	0.17 % of reading	
	6.7 W to 20 kW		
	(0 to 180)°		
	(10 to 65) Hz	0.11°	
Capacitance – Source <sup>1</sup> (Simulation)	(65 to 500) Hz	0.21°	Comparison to Fluke 5522A Multiproduct Calibrator
	500 Hz to 1 kHz	0.39°	
	(1 to 5) kHz	1.9°	
	(5 to 10) kHz	3.9°	
	(10 to 30) kHz	7.8°	
	10 Hz to 10 kHz		
	(220 to 400) pF	0.4 % of reading + 7.8 pF	
	(0.4 to 1.1) nF	0.4 % of reading + 7.8 pF	
	10 Hz to 3 kHz		
	(1.1 to 3.3) nF	0.4 % of reading + 7.8 pF	
	10 Hz to 1 kHz		
	(3.3 to 11) nF	0.21 % of reading + 7.8 pF	
	(11 to 33) nF	0.2 % of reading + 78 pF	
	(33 to 110) nF	0.21 % of reading + 78 pF	
	10 Hz to 1 kHz		
	(110 to 330) nF	0.2 % of reading + 0.23 nF	
(10 to 600) Hz			
(0.33 to 1.1) μF	0.21 % of reading + 0.78 nF		
(10 to 300) Hz			
(1.1 to 3.3) μF	0.21 % of reading + 2.3 nF		
(10 to 150) Hz			
(3.3 to 11) μF	0.2 % of reading + 7.8 nF		
(10 to 120) Hz			
(11 to 33) μF	0.32 % of reading + 23 nF		

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Capacitance – Source <sup>1</sup> (Simulation)	(10 to 80) Hz (33 to 110) $\mu$ F	0.37 % of reading + 78 nF	Comparison to Fluke 5522A Multiproduct Calibrator
	DC to 50 Hz (110 to 330) $\mu$ F	0.38 % of reading + 0.23 $\mu$ F	
	DC to 20 Hz (0.33 to 1.1) mF	0.35 % of reading + 0.78 $\mu$ F	
	DC to 6 Hz (1.1 to 3.3) mF	0.35 % of reading + 2.3 $\mu$ F	
	DC to 2 Hz (3.3 to 11) mF	0.35 % of reading + 7.8 $\mu$ F	
	DC to 0.6 Hz (11 to 33) mF	0.58 % of reading + 23 $\mu$ F	
	DC to 0.2 Hz (33 to 110) mF	0.85 % of reading + 78 $\mu$ F	
	Capacitance – Measure <sup>1</sup>	60 Hz to 1 kHz Up to 10 pF	
(10 to 100) pF		0.062 % of reading + 14 fF	
(0.1 to 1) $\mu$ F		0.027 % of reading + 14 fF	
(1 to 100) $\mu$ F		0.035 % of reading + 18 fF	
(0.1 to 1) mF		0.24 % of reading + 18 fF	
Scope Voltage – Source <sup>1</sup> DC Signal	into 50 $\Omega$	(-5.0 to 5.0) V 0.023 % of reading + 19 $\mu$ V	Comparison to Fluke 9500B Oscilloscope Calibrator
	into 1 M $\Omega$	(-200 to 200) V 0.023 % of reading + 19 $\mu$ V	
Scope Voltage – Source <sup>1</sup> Square Wave	10 Hz to 100 kHz into 50 $\Omega$	40 $\mu$ Vp-p to 1 mVp-p 1 mVp-p to 5 Vp-p	Comparison to Fluke 9500B Oscilloscope Calibrator, Fluke 9530 Active Head, Fluke 9560 Active Head
	10 Hz to 10 kHz into 1 M $\Omega$	40 $\mu$ Vp-p to 1 mVp-p	
	10 Hz to 100 kHz into 1 M $\Omega$	1 mVp-p to 200 Vp-p	
		0.078 % of reading + 7.8 $\mu$ V	



ANSI National Accreditation Board

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Scope – Time Markers <sup>1</sup> 100 mVp-p to 1 Vp-p (into 50 Ω) Square Wave Sine Wave Pulse Triangle Wave	9.009 1 ns to 83 μs 83 μs to 55 s 450.5 ps to 9.009 ns 900.91 ns to 83 μs 83 μs to 55 s 900.91 ns to 83 μs 83 μs to 55 s	0.19 μs/s 2.3 μs/s 0.19 μs/s 0.19 μs/s 2.3 μs/s 0.19 μs/s 2.3 μs/s	Comparison to Fluke 9500B Oscilloscope Calibrator, Fluke 9530 Active Head, Fluke 9560 Active Head
Scope Rise Time – Source <sup>1,4</sup> (into 50 Ω) 10 Hz to 2 MHz 10 Hz to 1 MHz	5 mVp-p to 3 Vp-p 500 ps (Nominal) 150 ps (Nominal) 25 mVp-p to 2 Vp-p 70 ps (Nominal)	290 ps 34 ps 21 ps	Comparison to Fluke 9500B Oscilloscope Calibrator with Fluke 9530 Active Head
Scope Levelled Sine Wave – Source <sup>1</sup> (50 kHz Ref. Frequency) into 50 Ω	5 mVp-p to 5 Vp-p 50 kHz to 10 MHz	1.2 % of reading	Comparison to Fluke 9500B Oscilloscope Calibrator with Fluke 9530 Active Head
Scope Bandwidth/Flatness – Source <sup>1</sup> into VSWR (1.2:1) (wrt Reference Frequency)	5 mVp-p to 5 Vp-p 100 MHz to 300 MHz (300 to 550) MHz 5 mVp-p to 3 Vp-p 550 MHz to 1.1 GHz (1.1 to 2.5) GHz 5 mVp-p to 2 Vp-p (2.5 to 3.2) GHz	1.6 % of reading 1.9 % of reading 2.7 % of reading 3.1 % of reading 3.1 % of reading	Comparison to Fluke 9500B Oscilloscope Calibrator, Fluke 9530 Active Head
Scope Input Impedance – Measure <sup>1</sup>	(10 to 40) Ω (40 to 90) Ω (90 to 150) Ω (50 to 800) kΩ 800 kΩ to 1.2 MΩ (1.2 to 12) MΩ	0.39 % of reading 0.083 % of reading 0.39 % of reading 0.39 % of reading 0.083 % of reading 0.39 % of reading	Comparison to Fluke 9500B Oscilloscope Calibrator



ANSI National Accreditation Board

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Scope Input Capacitance – Measure <sup>1</sup>	(1 to 35) pF (35 to 95) pF	1.6 % of reading + 0.19 pF 2.3 % of reading + 0.19 pF	Comparison to Fluke 9500B Oscilloscope Calibrator

**Electrical – RF/Microwave**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
RF Relative Power – Sinewave Flatness <sup>1</sup> (Relative Power)	10 MHz to 18 GHz		Comparison to Agilent E4419B EPM Power Meter, Agilent E4412A Power Sensor, Agilent E4413A Power Sensor
	(-40 to 0) dBm	0.21 dB	
	(0 to 10) dBm	0.34 dB	
	(10 to 20) dBm	0.51 dB	
	50 MHz to 26.5 GHz		
	(-40 to 00) dBm	0.25 dB	
RF Absolute Power – Measure <sup>1</sup> 100 pW to 100 mW	(0 to 10) dBm	0.39 dB	Comparison to Agilent E4419B EPM Power Meter, Agilent E4412A Power Sensor, Agilent E4413A Power Sensor
	(10 to 20) dBm	0.56 dB	
	10 MHz to 1 GHz		
	(-70 to -60) dBm	6.9 dB	
	(-60 to -50) dBm	1.4 dB	
	(-50 to -40) dBm	0.24 dB	
	(-40 to 0) dBm	0.17 dB	
	(0 to 10) dBm	0.34 dB	
	(10 to 20) dBm	0.51 dB	
	1 GHz to 18 GHz		
	(-70 to -60) dBm	6.9 dB	
	(-60 to -50) dBm	1.4 dB	
	(-50 to -40) dBm	0.25 dB	
	(-40 to 0) dBm	0.19 dB	
	(0 to 10) dBm	0.36 dB	
	(10 to 20) dBm	0.53 dB	
	50 MHz to 26.5 GHz		
	(-70 to -60) dBm	6.9 dB	
(-60 to -50) dBm	1.4 dB		
(-50 to -40) dBm	0.27 dB		
(-40 to 0) dBm	0.22 dB		
(0 to 10) dBm	0.39 dB		
(10 to 20) dBm	0.56 dB		

**Electrical – RF/Microwave**

<b>Parameter/Equipment</b>	<b>Range</b>	<b>Expanded Uncertainty of Measurement (+/-)</b>	<b>Reference Standard, Method, and/or Equipment</b>
Amplitude Modulation – AM Depth Measure <sup>1</sup>			
Rate 50 Hz to 10 kHz	(5 to 99) % Depth (0.15 to 10) MHz	2.4 % Depth	Comparison to HP 8902A Measuring Receiver, HP 11722A Power Sensor
Rate: 20 Hz to 10 kHz	(> 0 to 99) % Depth (0.15 to 10) MHz	3.5 % Depth	
Rate: 50 Hz to 50 kHz	(5 to 99) % Depth (0.01 to 1.3) GHz	1.4 % Depth	
Rate: 20 Hz to 100 kHz	(> 0 to 99) % Depth (0.01 to 1.3) GHz	3.5 % Depth	
Rate: 50 Hz to 50 kHz	(5 to 99) % Depth (1.3 to 26.5) GHz	1.9 % Depth	
Rate 20 Hz to 100 kHz	(> 0 to 99) % Depth (1.3 to 26.5) GHz	3.5 % Depth	
FM Modulation – Measure <sup>1</sup>			
Rate 50 Hz to 10 kHz	≤ 40 kHz peak 250 kHz to 10 MHz	2.4 % Deviation	Comparison to HP 8902A Measuring Receiver, HP 11722A Power Sensor
Rate: 50 Hz to 100 kHz	≤ 400 kHz peak 10 MHz to 26.5 GHz	1.4 % Deviation	
Rate: 20 Hz to 200 kHz	≤ 400 kHz peak 10 MHz to 26.5 GHz	5.8 % Deviation	
Phase Modulation – Measure <sup>1</sup>			
Rate: 200 Hz to 10 kHz	Up to 4 rad 150 kHz to 10 MHz	4.2 % of reading + 0.03 rad	Comparison to HP 8902A Measuring Receiver, HP 11722A Power Sensor
	(4 to 40) rad 150 kHz to 10 MHz	4.2 % of reading + 0.03 rad	
	(40 to 400) rad 150 kHz to 10 MHz	4.2 % of reading + 0.1 rad	
Phase Modulation – Measure <sup>1</sup>			
Rate: 200 Hz to 10 kHz	< 40 Radians Deviation (0.15 to 10) MHz	4.9% Deviation	Comparison to HP 8902A Measuring Receiver, HP 11722A Power Sensor, HP 11792A Microwave Converter, HP 11793A Microwave Converter
Rate: 200 Hz to 20 kHz	< 40 Radians Deviation (0.01 to 26.5) GHz	3.8% Deviation	

**Electrical – RF/Microwave**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Harmonic Distortion	(-80 to 0) dBc 30 Hz to 6.5 GHz (6.5 to 22) GHz (22 to 26.5) GHz	1.7 dB 2.6 dB 3.4 dB	Comparison to Agilent 8563E Spectrum Analyzer
Total Harmonic Distortion – Measure <sup>1</sup>	(-80 to 0) dB 20 Hz to 20 kHz (20 to 100) kHz	1.1 dB 2 dB	Comparison to Agilent 8903B Audio Analyzer
AM Total Harmonic Distortion – Measure <sup>1</sup>	(-80 to 0) dB 20 Hz to 20 kHz 20 kHz to 100 kHz	1.2 dB 2.3 dB	Comparison to Agilent 8903B Audio Analyzer
Absolute RF Power – Measure <sup>1</sup>	1 mW, 50 MHz Reference	0.43 % of reading	Comparison to Agilent 478A- H75 Coaxial Thermistor Mount, HP 432A Power Meter, Agilent 3458A 8.5 Digit Multimeter
Absolute RF Power – Measure <sup>1</sup>	100 kHz to 2.6 GHz (-20 to -10) dBm (-10 to 0) dBm (0 to 10) dBm (10 to 20) dBm (20 to 30) dBm	0.11 dB 0.1 dB 0.11 dB 0.11 dB 0.23 dB	Comparison to HP 8902A Measuring Receiver, HP 11722A Power Sensor
Absolute RF Power – Measure <sup>1</sup>	(2.6 to 12.2) GHz (-20 to -10) dBm (-10 to 0) dBm (0 to 10) dBm (10 to 20) dBm (20 to 30) dBm (12.2 to 17.75) GHz (-20 to -10) dBm (-10 to 0) dBm (0 to 10) dBm (10 to 20) dBm (20 to 30) dBm (17.75 to 26.5) GHz (-20 to -10) dBm (-10 to 0) dBm (0 to 5) dBm	0.14 dB 0.13 dB 0.13 dB 0.14 dB 0.25 dB 0.15 dB 0.14 dB 0.14 dB 0.15 dB 0.25 dB 0.18 dB 0.18 dB 0.18 dB	Comparison to HP 8902A Measuring Receiver, HP 11722A Power Sensor, HP 11792A Microwave Converter, HP 11793A Microwave Converter



ANSI National Accreditation Board

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Reflection (VSWR) <sup>1,7</sup> 10 MHz to 18 GHz	(Rho) 0.022 to 0.1 0.1 to 0.2 0.2 to 0.3 0.3 to 0.4	(Rho) 0.022 0.027 0.033 0.042	Comparison to VSWR Bridge
Relative Tuned RF Power – Measure <sup>1</sup>	2.5 MHz to 26.5 GHz (-127 to -120) dB (-120 to -110) dB (-110 to -100) dB (-100 to -90) dB (-90 to -80) dB (-80 to -70) dB (-70 to -60) dB (-60 to -50) dB (-50 to -40) dB (-40 to -30) dB (-30 to -20) dB (-20 to -10) dB (-10 to 0) dB	0.056 dB 0.06 dB 0.064 dB 0.068 dB 0.071 dB 0.074 dB 0.081 dB 0.084 dB 0.22 dB 0.23 dB 0.23 dB 0.23 dB 0.23 dB	Comparison to HP 8902A Measuring Receiver, HP 11722A Power Sensor, HP 11793A Microwave Converter
Amplitude Modulation – AM Depth Measure <sup>1,6</sup> Rate: 50 Hz to 10 kHz Rate: 20 Hz to 10 kHz Rate: 50 Hz to 50 kHz	150 kHz to 10 MHz (5 to 99) % Depth 150 kHz to 10 MHz (5 to 99) % Depth 10 MHz to 1.3 GHz (5 to 99) % Depth	2.4 % Depth 3.5 % Depth 1.3 % Depth	Comparison to HP 8902A Measuring Receiver HP 8902A, HP 11793A Measuring Receiver Microwave Converter
Amplitude Modulation – AM Depth Measure <sup>1,6</sup> Rate: 20 Hz to 100 kHz Rate: 50 Hz to 50 kHz Rate: 20 Hz to 100 kHz	10 MHz to 1.3 GHz (0 to 99) % Depth (1.3 to 26.5) GHz (0 to 99) % Depth (1.3 to 26.5) GHz (0 to 99) % Depth	3.5 % Depth 1.8 % Depth 3.5 % Depth	Comparison to HP 8902A Measuring Receiver, HP 11793A Microwave Converter



ANSI National Accreditation Board

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Frequency Modulation – Deviation Measure <sup>1,6</sup> Rate: 20 Hz to 10 kHz	250 kHz to 10 MHz Dev/Rate ≤ 40 kHz peak	2.3 % Deviation	Comparison to HP 8902A Measuring Receiver
	10 MHz to 1.3 GHz Dev/Rate ≤ 400 kHz peak	1.2 % Deviation	
Frequency Modulation – Deviation Measure <sup>1,6</sup> Rate: 20 Hz to 200 kHz	10 MHz to 1.3 GHz Dev/Rate ≤ 4 kHz peak	5.8 % Deviation	Comparison to HP 8902A Measuring Receiver, HP 11793A Microwave Converter
	(1.3 to 26.5) GHz Dev/Rate ≤ 400 kHz peak	1.2 % Deviation	
	(1.3 to 26.5) GHz Dev/Rate ≤ 400 kHz peak	5.8 % Deviation	
RF Power – Transfer Measure	(-20 to 10) dBm 100 kHz to 10 MHz	0.97 % of reading	Comparison to Tegam 2505A Microwave Calibration Feed-through Standard, Tegam 1830A RF Power Meter
	> 10 MHz to 10 GHz	1.2 % of reading	
	(> 10 to 18) GHz	1.5 % of reading	
RF Power – Transfer Measure	(-20 to 10) dBm (10 to 50) MHz	1.5 % of reading	Comparison to Tegam 2510A Microwave Calibration Feed-through Standard, Tegam 1830A RF Power Meter
	> 10 MHz to 4.2 GHz	1.5 % of reading	
	(> 4.2 to 12.2) GHz	1.8 % of reading	
	(> 12.2 to 17.75) GHz	2 % of reading	
	(> 17.75 to 33) GHz	2.7 % of reading	
	(> 33 to 44) GHz	3.4 % of reading	
(> 44 to 50) GHz	4.8 % of reading		

**Electrical – RF/Microwave**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Tuned RF Absolute Power – Measure	2.5 MHz to 26.5 GHz		Comparison to HP 8902A Measuring Receiver, HP 11722A Power Sensor, HP 11792A Microwave Converter, HP 11793A Microwave Converter
	(-127 to -120) dB	0.26 dB	
	(-120 to -110) dB	0.26 dB	
	(-110 to -100) dB	0.26 dB	
	(-100 to -90) dB	0.26 dB	
	(-90 to -80) dB	0.26 dB	
	(-80 to -70) dB	0.25 dB	
	(-70 to -60) dB	0.25 dB	
	(-60 to -50) dB	0.25 dB	
	(-50 to -40) dB	0.25 dB	
	(-40 to -30) dB	0.14 dB	
	(-30 to -20) dB	0.14 dB	
(-20 to -10) dB	0.14 dB		
(-10 to 0) dB	0.14 dB		

**Length – Dimensional Metrology**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Angle Measuring Devices <sup>2</sup> (Protractors, Inclinometers, Squares, Angle Gages, etc.)	Up to 5°	3.2"	Comparison to Sine Plate, Gage Blocks, Surface Plate
	(5 to 20)°	6.1"	
	(20 to 35)°	10.7"	
	(35 to 45)°	15"	
	(45 to 60)°	25.7"	
	(60 to 75)°	55.1"	
Outside Micrometers <sup>1,2</sup>	(0.05 to 1) in	(13 + 1L) μin	Comparison to ASME B89 Grade 0 Gage Blocks, ASME B89 Grade 0 Long Blocks
	(1 to 9) in	(9 + 4L) μin	
	(4 to 15) in	(14 + 4L) μin	
	(15 to 40) in	(20 + 4L) μin	
Anvil Flatness <sup>1</sup>	Up to 1 in Diameter	6.3 μin	Comparison to Optical Flats
Anvil Parallelism <sup>1</sup>	Up to 1 in Diameter	6.3 μin	Comparison to Optical Parallel
Calipers <sup>1,2</sup>	(0.05 to 1) in	(13 + 1L) μin	Comparison to ASME B89 Grade 0 Gage Blocks, ASME B89 Grade 0 Long Blocks
	(1 to 9) in	(9 + 4L) μin	
	(4 to 15) in	(14 + 4L) μin	
	(15 to 40) in	(20 + 4L) μin	

This Scope of Accreditation, version 018 was last updated on: 30 January 2026 and is valid only when accompanied by the Certificate.

Page 21 of 27

**Length – Dimensional Metrology**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Jaw Parallelism <sup>1</sup>	Up to 1 in	59 μin	Comparison to Pin Gages
Dial Indicators <sup>1,2</sup>	(0.05 to 1) in (1 to 6) in	(14 + 3L) μin (15 + 4L) μin	Comparison to ASME B89 Grade 0 Gage Blocks
Height Measure, Height Gages <sup>1,2</sup>	(0.05 to 1) in (1 to 9) in (4 to 15) in (15 to 40) in	57 μin (54 + 2L) μin (48 + 3L) μin (34 + 4L) μin	Comparison to ASME B89 Grade 0 Gage Blocks, Gage Amp w/Probe, Surface Plate
Single Axis Length <sup>2</sup>	up to 4 in (4 to 10) in	(15 + 3L) μin (14 + 4L) μin	Comparison to P&W Supermicrometer <sup>®</sup> , ASME B89 Grade 0 Gage Blocks
Plain Plugs, Pin Gages <sup>2</sup>	Up to 1 in	(15 + 3 L) μin	Comparison to P&W Supermicrometer <sup>®</sup> , ASME B89 Grade 0 Gage Blocks
Threaded Plug Gage <sup>2</sup> Outer Pitch Diameter, 60°	Up to 5 in (5 to 10)	110 μin 110 μin	Comparison to P&W Supermicrometer <sup>®</sup> , ASME B89 Grade 0 Gage Blocks, Thread Wires
Major Diameter	up to 4 in (4 to 10) in	(15 + 3 L) μin (14 + 4 L) μin	
Rulers and Tapes	up to 25 in (2 to 4) ft (4 to 6) ft (6 to 8) ft (8 to 22) ft (22 to 48) ft (48 to 1 000) ft	0.003 5 in 0.004 5 in 0.006 7 in 0.009 3in 100 μin/in 110 μin/in 120 μin/in	Comparison to Magnified Glass Rule
Surface Plates <sup>1</sup> Local Area Flatness Only	Up to 0.001 in	65 μin	Partial Calibration using Gage Amp w/Probe, Level Plate
Surface Plates <sup>1</sup> Local Area Flatness Only	Up to 0.001 in	33 μin	Partial Calibration using Repeat-o-Meter
Surface Parallelism <sup>1</sup>	Up to 18 in	120 μin	Comparison to Gage Amp w/Probe, Surface Plate

**Length – Dimensional Metrology**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Surface Straightness <sup>1</sup>	Up to 18 in	120 µin	Comparison to Gage Amp w/Probe, Surface Plate

**Mass and Mass Related**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Force – Source <sup>1</sup>	(0.1 to 915) lbf	0.024 % of reading + 0.001 2 lbf	Comparison to NIST Class F Weights
Torque Wrenches <sup>1</sup>	(0.2 to 10) N·m (0.4 to 20) N·m (2 to 100) N·m (4 to 200) N·m (8 to 400) N·m (25 to 1 100) N·m	1 % of reading 1 % of reading 1 % of reading 1 % of reading 1 % of reading 1 % of reading	Comparison to Stahlwille Torque Transducers
Torque Wrenches <sup>1</sup>	(900 to 2 000) lbf·ft	1.5 % of reading	Comparison to CDI 200-14-02 Torque Transducer
Torque Transducers <sup>1</sup>	0.156 lbf·in to 150 lbf·ft	0.17 % of reading	Comparison to Torque Arms/Wheels, NIST Class F Weights
Pneumatic Pressure – Source/Measure <sup>1</sup> (Absolute)	(0 to 15) psia (15 to 30) psia	0.001 5 psi 0.01 % of reading	Comparison to Mensor CPC6000 Pressure Controller
Pneumatic Pressure – Source/Measure <sup>1</sup> (Absolute)	(30 to 50) psia	0.006 6 % of reading + 0.005 7 psi	Comparison to Fluke 6270A Pressure Controller
Pneumatic Pressure – Source/Measure <sup>1</sup> (Absolute)	(50 to 300) psia (300 to 1 000) psia	0.004 5 % of reading + 0.006 4 psi 0.005 2 % of reading + 0.001 5 psi	Comparison to Fluke PPC4 Pressure Controller
Pneumatic Pressure – Source/Measure <sup>1</sup> (Gauge)	(-14.7 to 0) psig	0.006 2 % of reading + 0.000 1 psi	Comparison to Fluke PPC4 Pressure Controller
Pneumatic Pressure – Source/Measure <sup>1</sup> (Gauge)	(0 to 1) psig	0.000 1 psi	Comparison to Mensor CPC6000 Pressure Controller



ANSI National Accreditation Board

**Mass and Mass Related**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Pneumatic Pressure – Source/Measure <sup>1</sup> (Gauge)	(1 to 1 000) psig	0.006 2 % of reading + 0.000 1 psi	Comparison to Fluke PPC4 Pressure Controller
Hydraulic Pressure – Source/Measure <sup>1</sup> (Gauge)	(15 to 800) psig (800 to 16 000) psig	0.025 % of reading + 0.005 psi 0.02 % of reading + 0.095 psi	Comparison to Fluke P3125-DWT Deadweight Tester
Balances, Scales <sup>1,4</sup> (SI)	Up to 500 mg 500 mg to 5 g 5 g to 10 g 10 g to 30 g 30 g to 16 kg	12 µg 40 µg 58 µg 89 µg 0.000 32 % of reading	ASTM E617 Class 1 weights and internal calibration procedure utilized for the calibration of the weighing system.
Balances, Scales <sup>1,4</sup> (Avoirdupois)	Up to 0.018 oz (0.018 to 0.18) oz (0.18 to 0.35) oz (0.35 to 0.7) oz 0.7 oz to 35 lb	12 µg 40 µg 58 µg 89 µg 0.000 32 % of reading	ASTM E617 Class 1 weights and internal calibration procedure utilized for the calibration of the weighing system.
Balances, Scales <sup>1,4</sup> (SI)	Up to 8 g (8 to 226) g (226 to 453) g 453 g to 5 kg (5 to 6) kg (6 to 415) kg	2 mg 0.024 % of reading 0.018 % of reading 0.012 % of reading 0.01 % of reading 0.012 % of reading	NIST Class F weights and internal calibration procedure utilized for the calibration of the weighing system.
Balances, Scales <sup>1,4</sup> (Avoirdupois)	Up to 0.25 oz (0.25 to 8) oz (0.5 to 1) lb (1 to 11) lb (11 to 14) lb (14 to 915) lb	2 mg 0.024% of reading 0.018% of reading 0.012% of reading 0.010% of reading 0.012% of reading	NIST Class F weights and internal calibration procedure utilized for the calibration of the weighing system.
Volumetric Gas Flow	(0 to 0.002 44) CFM (0 to 0.048 43) CFM (0 to 0.179 05) CFM (0 to 0.765 26) CFM (0 to 7.5) CFM (0 to 40) CFM	1.2 % of reading 1.5 % of reading 1.6 % of reading 1.3 % of reading 1.2 % of reading 0.7 % of reading	Comparison to Merium Laminar Flow Elements



ANSI National Accreditation Board

**Thermodynamic**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Temperature – Source <sup>1</sup> (Thermometers, Probes, etc.)	(-30 to 0) °C (0 to 125) °C (-15 to 50) °C (50 to 100) °C (100 to 350) °C	0.04 °C 0.046 °C 0.59 °C 0.17 °C 0.14 °C	Comparison to Water Baths, Dry-well Calibrators, SPRT
Temperature – Measure <sup>1</sup>	(-195 to 0) °C (0 to 420) °C (420 to 660) °C	0.027 °C 0.007 5 % of reading + 0.027 °C 0.008 % of reading + 0.024 °C	Comparison to Fluke 1523 Reference Thermometer, Fluke 5626 PRT
Humidity – Measure <sup>1</sup> (15 to 25 °C)	(0 to 90) %RH	1.3 % RH	Comparison to Vaisala MI70/HMP76B Temp/Humidity Probe
Infrared Temperature – Measuring Equipment <sup>1</sup>	(-15 to 0) °C (0 °C to 50) °C (50 °C to 100) °C (100 °C to 120) °C (120 °C to 200) °C (200 °C to 350) °C (350 °C to 500) °C	0.8 °C 0.65 °C 0.7 °C 0.76 °C 0.95 °C 1.6 °C 2.1 °C	Comparison to Blackbody Source (Plate) ε = (0.9 to 1) λ = (8 to 14) μm

**Time and Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Frequency – Reference <sup>1</sup>	10 MHz	640 pHz/Hz	Comparison to Rubidium Oscillator
Frequency – Measure <sup>1</sup>	10 mHz to 100 kHz 100 kHz to 10 MHz (10 to 100) MHz (100 to 225) MHz	4.8 mHz 0.45 Hz 4.5 Hz 10 Hz	Comparison to HP 53132A Universal Counter, Rubidium Oscillator
Frequency – Measure <sup>1</sup>	225 MHz to 1 GHz (1 to 10) GHz (10 to 50) GHz	0.86 Hz 7.5 Hz 37 Hz	Comparison to Agilent E4448A Spectrum Analyzer, Rubidium Oscillator
Frequency – Source <sup>1</sup>	0.01 Hz to 2 MHz	2 μHz/Hz + 8 μHz	Comparison to Fluke 5522A Multiproduct Calibrator

**Time and Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Frequency – Source <sup>1</sup>	10 mHz to 100 kHz 100 kHz to 20 MHz	2 mHz 18 mHz	Comparison to HP 3325B Synthesizer/Function Generator, Rubidium Oscillator
Frequency – Source <sup>1</sup>	250 kHz to 1 GHz (1 to 50) GHz	0.74 Hz 37 Hz	Comparison to Agilent E8257D Analog Frequency Generator, Rubidium Oscillator
Stopwatches, Timers <sup>1</sup>	Up to 24 hr	0.02 % of reading + 38 ms	Comparison to Fluke 5522A Multiproduct Calibrator, HP 53132A Universal Counter
Photo Tachometers <sup>1,2</sup>	(10 to 999.9) rpm (1 000 to 99 999) rpm	0.058 % of reading + 0.12 rpm 0.082 % of reading + 1.2 rpm	Comparison to Extech 461995 Laser Tachometer
AC Duty Cycle – Source <sup>1</sup> Square Wave: < 3.3 Vp-p Freq: 0.1 Hz to 100 kHz	(1 to 10) % Duty Cycle 10 μs to 100 s (10 to 49) % Duty Cycle 10 μs to 100 s 50 % Duty Cycle 10 μs to 100 s (51 to 90) % Duty Cycle 10 μs to 100 s (90 to 99) % Duty Cycle 10 μs to 100 s	0.62 % of reading + 78 ns 0.039 % of reading + 78 ns 0.001 6 % of reading + 78 ns 0.039 % of reading + 78 ns 0.62 % of reading + 78 ns	Comparison to Fluke 5522A Multiproduct Calibrator

Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 ( $k=2$ ), corresponding to a confidence level of approximately 95%.

Notes:

1. On-site calibration service is available for this parameter, since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope.
2. L = length in inches; " = arc-second; rpm = revolutions per minute.
3. The stated uncertainty is the laboratory's ability to source a fast rise pulse that is approximately 250 ps. In the typical application of measuring rise time of an oscilloscope, this value is one of the contributing factors, but other factors are derived from the DUT. The known source rise time is mathematically removed from the total measured rise time measured on the DUT.
4. The CMC for scales and balances is highly dependent upon the resolution of the unit under test. The CMC presented here does not include the resolution of the unit under test. The resolution will be included in the reported measurement uncertainty at the time of calibration.

5. The uncertainties shown are for the most favorable conditions. There is an increase in uncertainty that corresponds to the laboratory's AC voltage and current uncertainties at different frequencies other than the ones shown. Power factors (PF) other than the one shown contribute to the power uncertainty. PF is related to the cosine of phase. Therefore, uncertainties track the laboratory's phase uncertainty closely at PF near one, but are magnified heavily as PF approaches zero. The lab may also report reactive power, apparent power, and power factor under this accreditation. If needed, contact laboratory for more information regarding uncertainties at frequency and power factor combinations other than the ones shown.
6. In addition to the percent of reading value for the CMC, 1 Least Significant Digit will be added at the time of calibration.
7. This is a unitless measurement.
8. Repeatability has not been considered in the Scope Uncertainty presented here. It will be factored in to the Measurement Uncertainty (MU) at the time of calibration.
9. Unless otherwise specified in the far-right column, the calibration procedure/method utilized by the laboratory was developed internally.
10. The legal entity for this site is Transcat, Inc.



Jason Stine, Vice President

